



FCB20N60 600V N-Channel MOSFET

Features

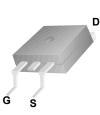
- 650V @T_J = 150°C
- Typ. R_{DS(on)} = 0.15Ω
- Ultra low gate charge (typ. Q_g = 75nC)
- Low effective output capacitance (typ. C_{oss}.eff = 165pF)
- 100% avalanche tested
- RoHS Compliant

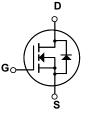


Description

SuperFETTM is, Fairchild's proprietary, new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance.

This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. Consequently, SuperFET is very suitable for various AC/DC power conversion in switching mode operation for system miniaturization and higher efficiency.





Absolute Maximum Ratings

Symbol	Parameter			FCB20N60	Unit	
V _{DSS}	Drain-Source Voltage			600	V	
I _D	Drain Current	- Continuous (T _C = 2 - Continuous (T _C = 1		20 12.5	A A	
I _{DM}	Drain Current	- Pulsed (Note 1)		60	A	
V _{GSS}	Gate-Source voltage			± 30	V	
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	690	mJ	
I _{AR}	Avalanche Current		(Note 1)	20	А	
E _{AR}	Repetitive Avalanche Energy		(Note 1)	20.8	mJ	
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.5	V/ns	
P _D	Power Dissipation $(T_C = 25^{\circ}C)$ - Derate above $25^{\circ}C$			208 1.67	W ₩/°C	
T _{J,} T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C	
Τ _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C	

Thermal Characteristics

Symbol	Parameter	FCB20N60	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.6	°C/W	
$R_{\theta JA}^{*}$	Thermal Resistance, Junction-to-Ambient*	40	°C/W	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	62.5	°C/W	
	the minimum pad size recommended (PCB Mount			

Device Marking		Device	Pac	ckage Reel Size Tap		24m		Quantity 800		
FCB20	-		-PAK 330mm							
Electric	al Char	racteristics T _c	= 25°C unle	ss otherwise no	ted					
Symbol		Parameter			Conditions		Min	Тур	Max	Units
Off Charac	teristics									
BV _{DSS}	Drain-Source Breakdown Voltage		V_{GS} = 0V, I_{D} = 250 μ A, T_{J} = 25°C		600			V		
			$V_{GS} = 0V, I_D = 250\mu A, T_J = 150^{\circ}C$			650		V		
ΔΒV _{DSS} / ΔΤ _J	Breakdown Voltage Temperature Coefficient		$I_D = 250\mu A$, Referenced to $25^{\circ}C$			0.6		V/°C		
BV _{DS}	Drain-Source Avalanche Breakdown Voltage		V _{GS} = 0V, I _D = 20A			700		V		
I _{DSS}	Zero Gate Voltage Drain Current			V _{DS} = 600V, V _{GS} = 0V V _{DS} = 480V, T _C = 125°C				1 10	μΑ μΑ	
I _{GSSF}	Gate-Bod	ody Leakage Current, Forward		$V_{GS} = 30V, V_{DS} = 0V$				100	nA	
I _{GSSR}	Gate-Bod	ly Leakage Current, Reverse		$V_{GS} = -30V, V_{DS} = 0V$				-100	nA	
On Charac	teristics			1						
V _{GS(th)}	Gate Threshold Voltage			$V_{DS} = V_{GS}$	₃ , I _D = 250μA		3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance		V _{GS} = 10V, I _D = 10A			0.15	0.19	Ω		
9 _{FS}	Forward 1	rd Transconductance		V _{DS} = 40V	′, I _D = 10A	(Note 4)		17		S
Dynamic C	haracteris	tics								
C _{iss}	Input Capacitance Output Capacitance		V _{DS} = 25V, V _{GS} = 0V, f = 1.0MHz			2370	3080	pF		
C _{oss}						1280	1665	pF		
C _{rss}	Reverse Transfer Capacitance					95		pF		
C _{oss}	Output Capacitance		V _{DS} = 480	V_{DS} = 480V, V_{GS} = 0V, f = 1.0MHz			65	85	pF	
C _{oss} eff.	Effective Output Capacitance		V_{DS} = 0V to 400V, V_{GS} = 0V			165		pF		
Switching	Characteri	stics								
t _{d(on)}	Turn-On Delay Time		$V_{DD} = 300V, I_D = 20A$			62	135	ns		
t _r	Turn-On F	Rise Time		$R_{G} = 25\Omega$			140	290	ns	
t _{d(off)}	Turn-Off E	Delay Time					230	470	ns	
t _f	Turn-Off F	Fall Time				(Note 4, 5)		65	140	ns
Qg	Total Gate	e Charge		$V_{DS} = 480V, I_D = 20A$ $V_{GS} = 10V$			75	98	nC	
Q _{gs}	Gate-Sou	rce Charge					13.5	18	nC	
Q _{gd}	Gate-Drai	n Charge				(Note 4, 5)		36		nC
Drain-Soui	rce Diode (Characteristics and I	Maximun	n Ratings					I	1
I _S	Maximum Continuous Drain-Source Diod		le Forward Current				20	A		
I _{SM}	Maximum Pulsed Drain-Source Diode Fo		orward Current				60	Α		
V _{SD}	Drain-Sou	Irce Diode Forward Vo	oltage	V_{GS} = 0V,	-				1.4	V
t _{rr}	Reverse F	Recovery Time		$V_{GS} = 0V,$		<i></i>		530		ns
Q _{rr}	Reverse F	Recovery Charge		dI _F /dt =100A/μs (Note 4		(Note 4)		10.5		μC

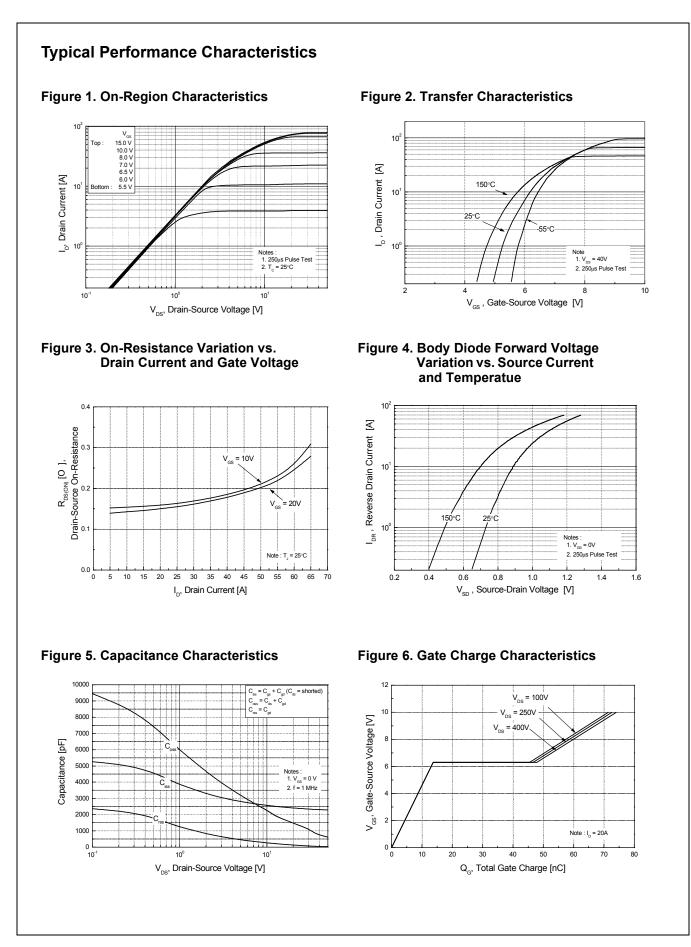
1. Repetitive Rating: Pulse width limited by maximum junction temperature

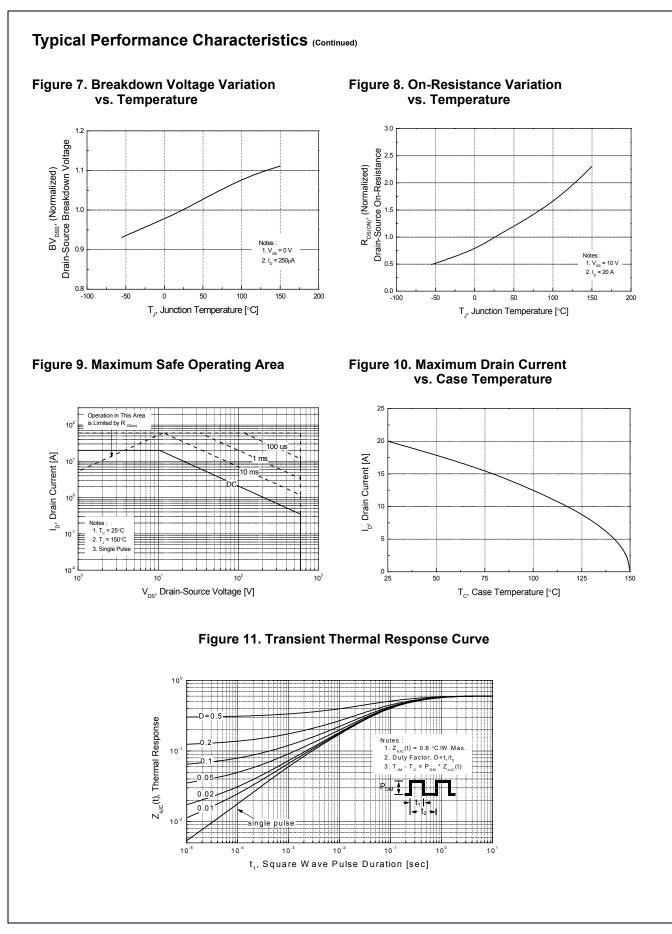
2. I_{AS} = 10A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}C$

3. I_{SD} \leq 20A, di/dt \leq 200A/µs, V_{DD} \leq BV_{DSS}, Starting T_J = 25°C

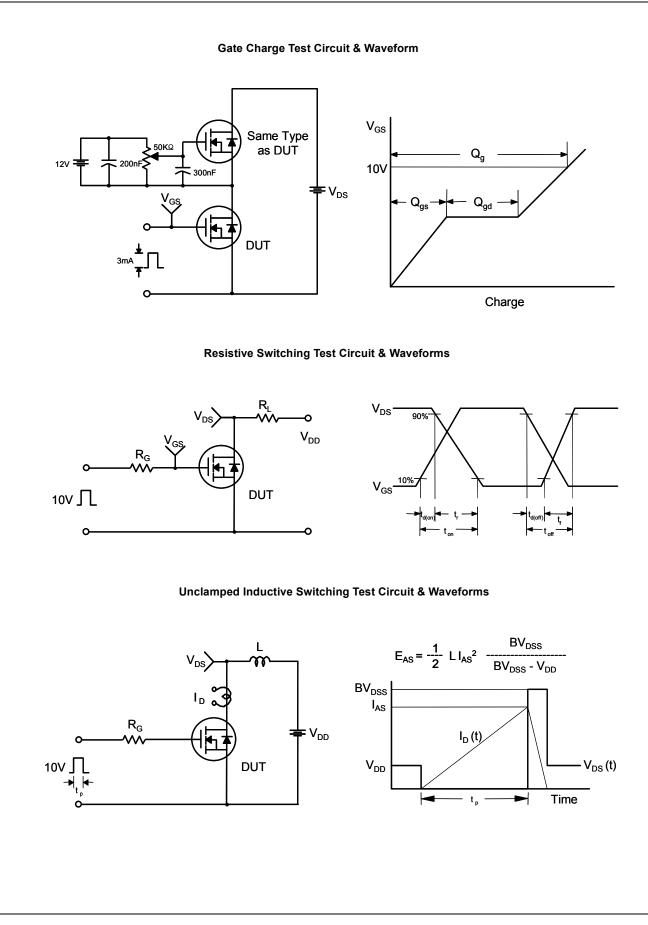
4. Pulse Test: Pulse width $\leq 300 \mu s,$ Duty Cycle $\leq 2\%$

5. Essentially Independent of Operating Temperature Typical Characteristics



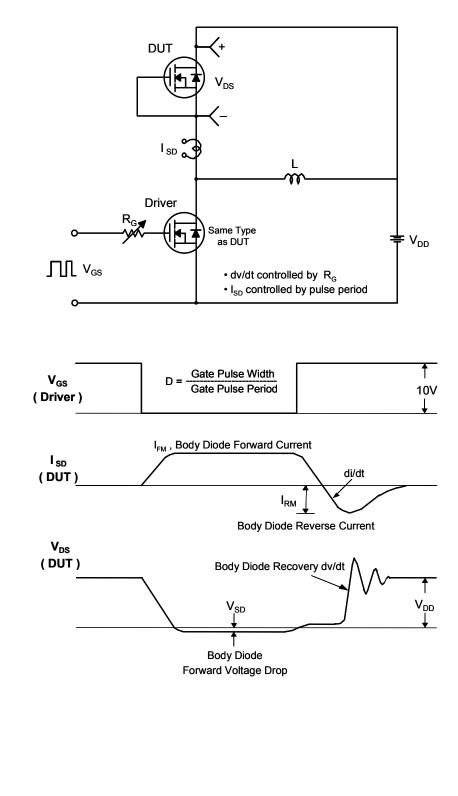


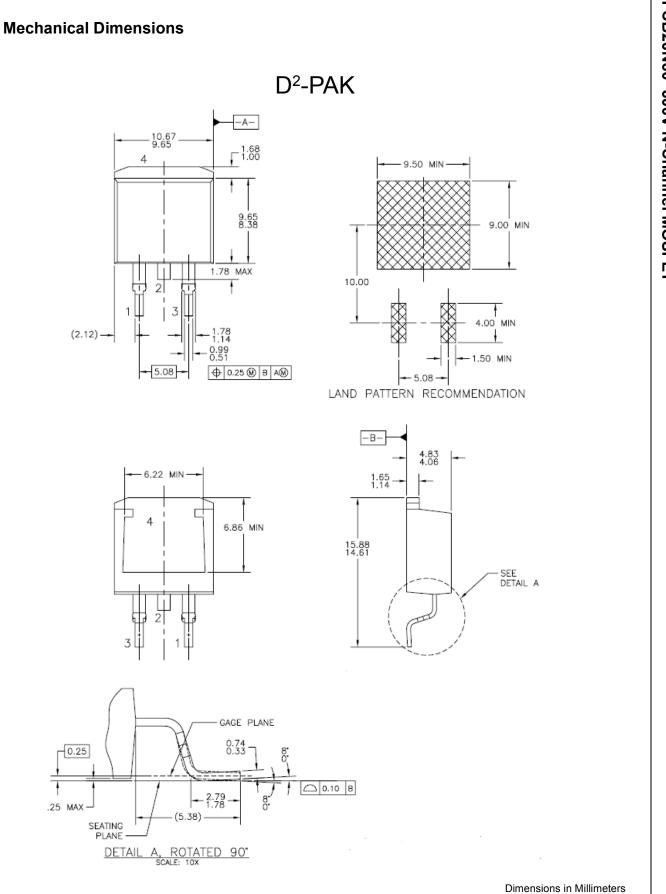
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Peak Diode Recovery dv/dt Test Circuit & Waveforms







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